



# HIGH SPEED NPN POWER DARLINGTON TRANSISTORS

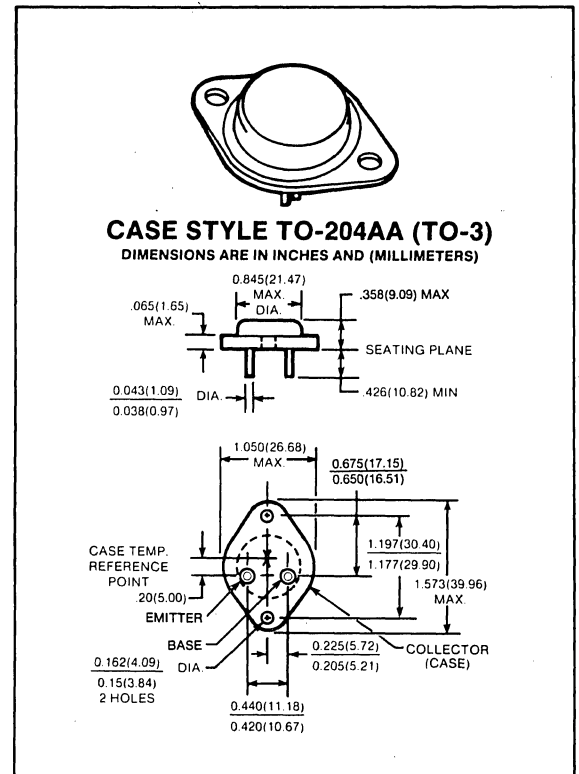
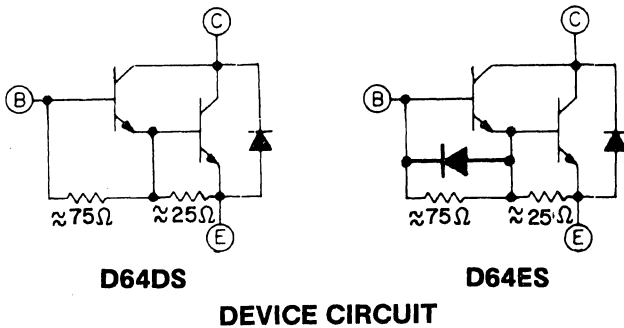
**D64DS5,6,7  
D64ES5,6,7**

**400-500 VOLTS  
20 AMP, 125 WATTS**

These devices are designed for use in high-speed switching applications, such as off-line switching power supplies PWM DC and AC motor control, UPS, ultrasonic equipment and other high frequency power conversion equipment.

**Features:**

- High Speed:  $t_s < 3.0 \mu\text{sec.}$ ,  $t_r < 1.0 \mu\text{sec.}$
- High Voltage: 400-500  $V_{CEO(SUS)}$
- High Gain:  $h_{FE}$  40 Minimum @  $I_C = 20A$
- High Current: 30 Amperes,  $I_C$  (Peak)



maximum ratings ( $T_C = 25^\circ C$ ) (unless otherwise noted)

RATING	SYMBOL	D64DS5/ES5	D64DS6/ES6	D64DS7/ES7	UNITS
Collector-Emitter Voltage	$V_{CEV}$	500	600	700	Volts
Collector-Emitter Voltage	$V_{CEO}$	400	450	500	Volts
Emitter Base Voltage	$V_{EBO}$	8	8	8	Volts
		5	5	5	
Collector Current — Continuous	$I_C$	20	20	20	A
Peak (Repetitive)	$I_{CM}$	30	30	30	
Peak (Non-Repetitive)	$I_{CSM}$	50	50	50	
Base Current — Continuous	$I_B$	5	5	5	A
Peak (Non-Repetitive)	$I_{BM}$	10	10	10	
Total Power Dissipation @ $T_C = 25^\circ C$	$P_D$	125	125	125	Watts
Operating and Storage Junction Temperature Range	$T_J, T_{STG}$	-65 to +150	-65 to +150	-65 to +150	$^\circ C$

**thermal characteristics**

Thermal Resistance, Junction to Case	$R_{\theta JC}$	1	1	1	$^\circ C/W$
Maximum Lead Temperature for Soldering Purposes: 1/8" from Case for 5 Seconds	$T_L$	300	300	300	$^\circ C$

electrical characteristics ( $T_C = 25^\circ C$ ) (unless otherwise specified)

CHARACTERISTIC	SYMBOL	MIN	TYP	MAX	UNIT
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off characteristics

Collector-Emitter Sustaining Voltage ( $I_C = .5A$ ) ( $V_{clamp} = V_{CEO}$ Rated)	D64DS5/ES5 D64DS6/ES6 D64DS7/ES7	$V_{CEO(sus)}$	400 450 500	— — —	— — —	Volts
Collector Cutoff Current ( $V_{CE} =$ Rated Value, $V_{BE} = -1.5V$ )	$T_J = 25^\circ C$ $T_J = 150^\circ C$	$I_{CEV}$	— —	— —	1.0 2.5	mA
Emitter Cutoff Current ( $V_{EB} = 4.5V, I_C = 0$ ) ( $V_{EB} = 1.5V, I_C = 0$ )	D64DS D64ES	$I_{EBO}$	— —	— —	200 200	mA

second breakdown

Second Breakdown with Base Forward Biased	FBSOA	SEE FIGURE 26
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on characteristics

DC Current Gain ( $I_C = 30A, V_{CE} = 5V$ ) ( $I_C = 20A, V_{CE} = 5V$ ) ( $I_C = 10A, V_{CE} = 5V$ )	$h_{FE}$	20 40 100	35 85 160	— — —	—
Collector-Emitter Saturation Voltage ( $I_C = 30A, I_B = 3A$ ) ( $I_C = 20A, I_B = 2A$ ) ( $I_C = 10A, I_B = 1A$ )	$V_{CE(sat)}$	— — —	2.1 1.6 1.2	3.5 2.5 1.5	V
Base-Emitter Saturation Voltage ( $I_C = 30A, I_B = 3A$ ) ( $I_C = 20A, I_B = 2A$ ) ( $I_C = 10A, I_B = 1A$ )	$V_{BE(sat)}$	— — —	2.65 2.3 1.8	4 3 2.5	V

switching characteristics

		TYP.				MAX.		
			DS	ES	DS	ES		
Resistive Load								
Delay Time	$V_{CC} = 250V$	$t_d$	—	.05	.05	.5	.5	$\mu s$
Rise Time	$I_C = 20A$	$t_r$	—	.4	.4	1	1	
Storage Time	$I_{B1} = 1A, I_{B2} = 2A$	$t_s$	—	2.2	1.8	5	3	
Fall Time	$t_p = 50 \mu sec$	$t_f$	—	1.6	.45	3	1	

emitter-collector diode characteristics

Power Dissipation ( $I_{B1} = 0$ )	$P_D$	—	—	125	Watts
Forward Voltage ( $I_F = 10A$ ) ( $I_P = 25A$ ) ( $I_F = 25A, T_J = 150^\circ C$ )	$V_F$ $V_F$ $V_F$	— — —	1.95 2.80 2.75	3.20 4.00 4.00	Volts Volts Volts
Reverse Recovery Time ( $I_F = 25A, di/dt = 15A/\mu sec, R_{B1E} = .25\Omega$ )	$T_{rr}$	—	3.85	10	$\mu sec$
Forward Turn-On Time ( $I_F = 25A, di/dt = 50A/\mu sec$ )	$T_{ON}$	—	0.42	1.0	$\mu sec$
Single Cycle Surge Current (60Hz)	$I_{FSM}$	—	—	50	Amps
Thermal Resistance	$R_{\theta JC}$	—	—	1.0	$^\circ C/Watt$

# TYPICAL CHARACTERISTICS

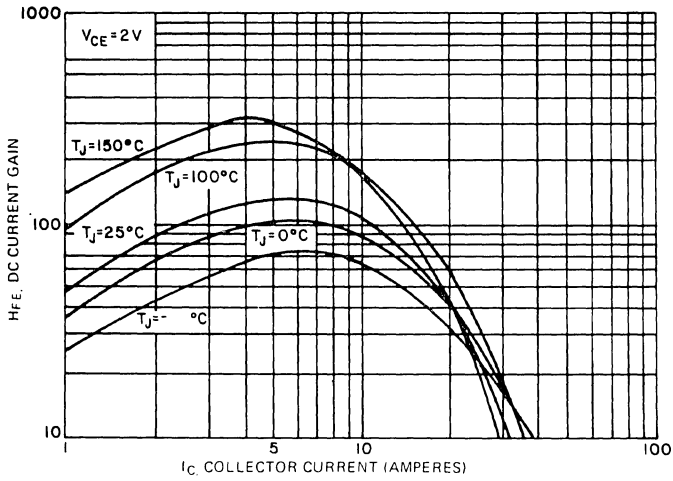


FIGURE 1. DC CURRENT GAIN ( $V_{CE} = 2V$ )

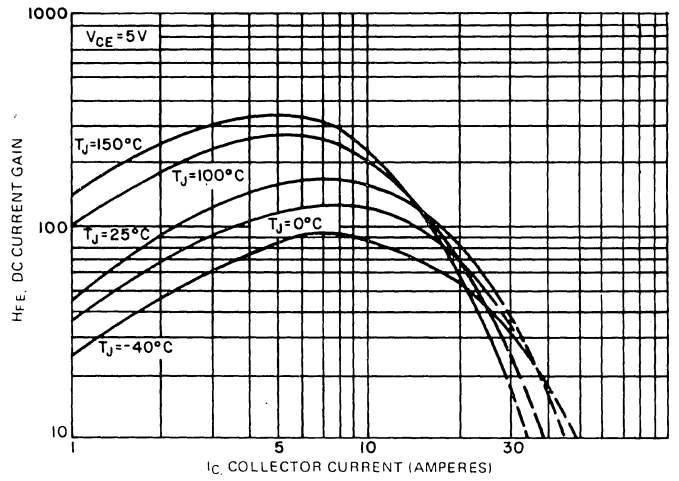


FIGURE 2. DC CURRENT GAIN ( $V_{CE} = 5V$ )

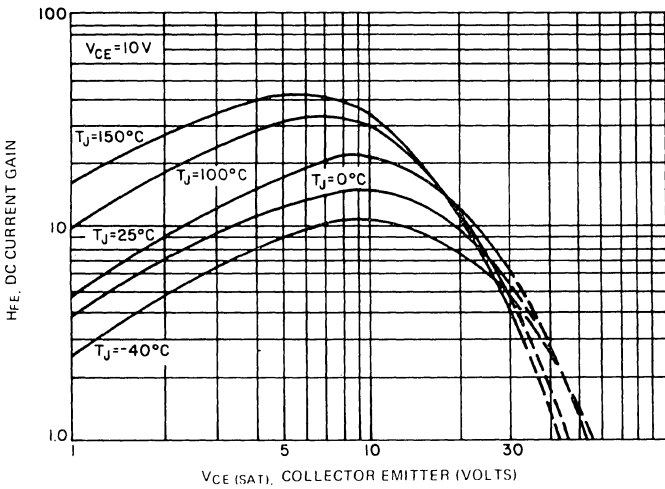


FIGURE 3. DC CURRENT GAIN ( $V_{CE} = 10V$ )

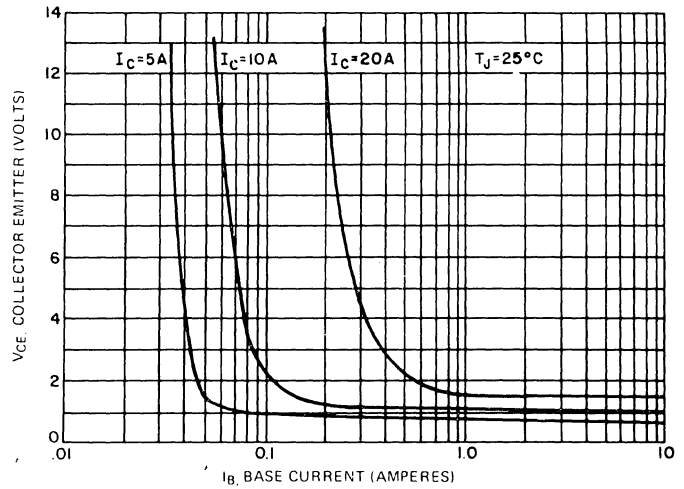


FIGURE 4. COLLECTOR SATURATION REGION

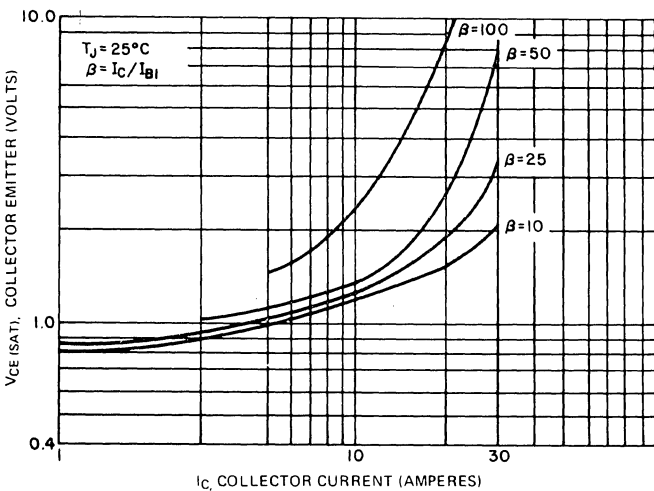


FIGURE 5.  $V_{CE(SAT)}$  VS.  $I_C$ ,  $T_J = 25^\circ C$

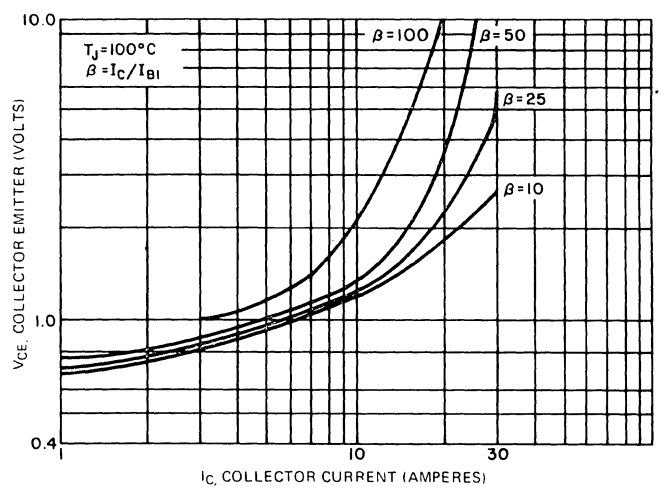
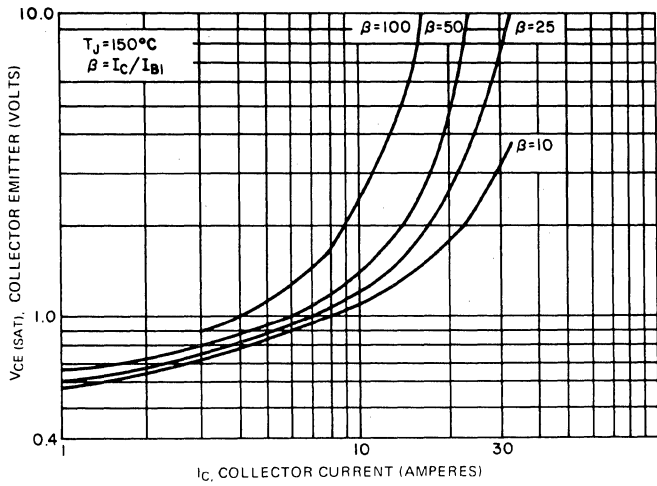
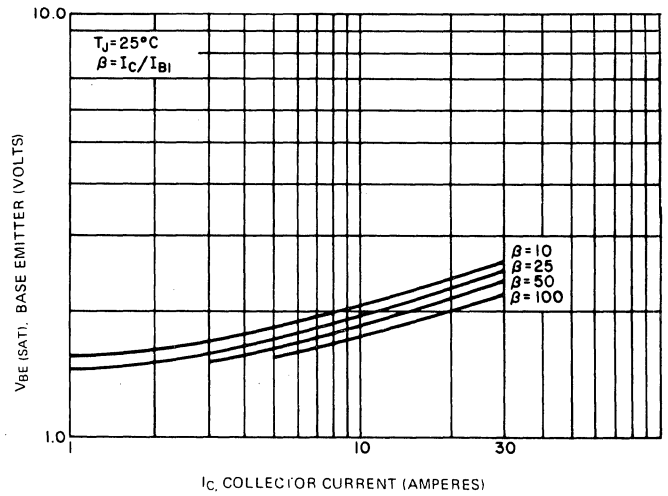


FIGURE 6.  $V_{CE(SAT)}$  VS.  $I_C$ ,  $T_J = 100^\circ C$

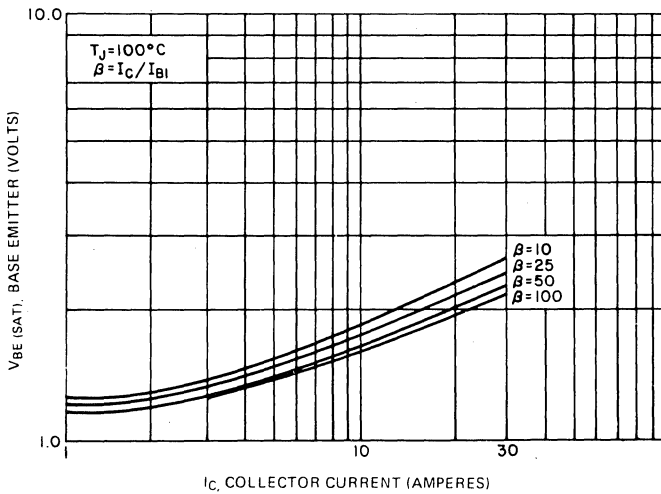
## TYPICAL CHARACTERISTICS



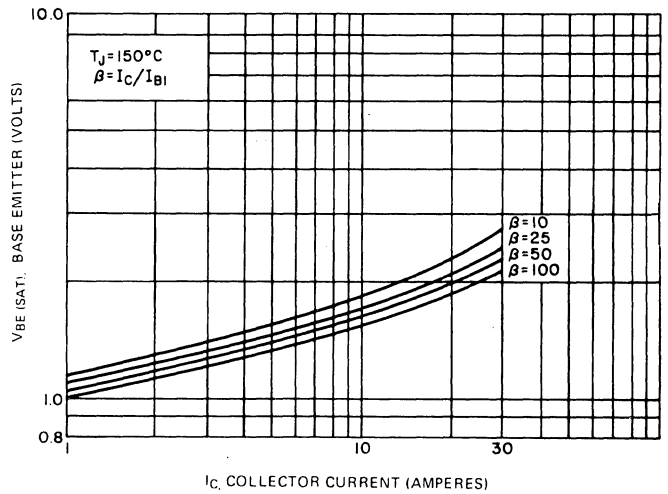
**FIGURE 7.  $V_{CE(SAT)}$  VS.  $I_C$ ,  $T_J = 150^\circ\text{C}$**



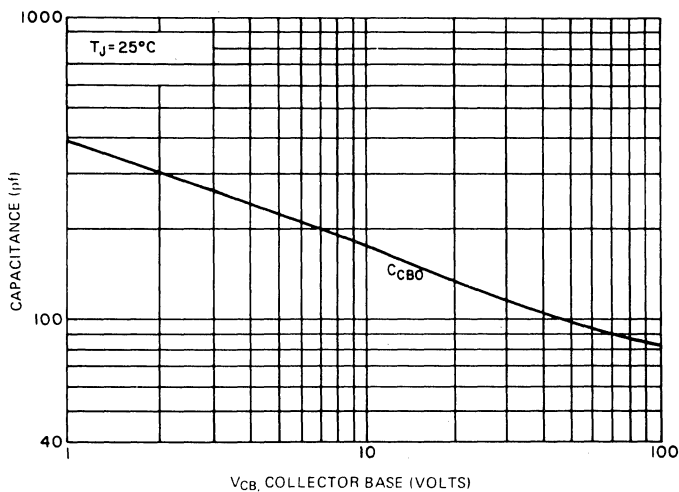
**FIGURE 8.  $V_{BE(SAT)}$  VS.  $I_C$ ,  $T_J = 25^\circ\text{C}$**



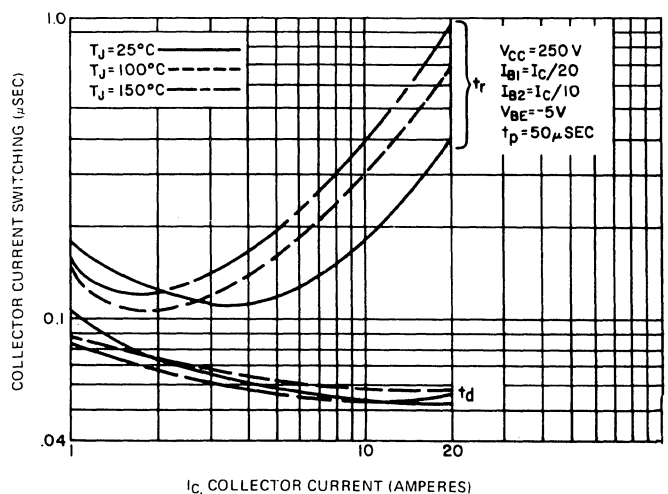
**FIGURE 9.  $V_{BE(SAT)}$  VS.  $I_C$ ,  $T_J = 100^\circ\text{C}$**



**FIGURE 10.  $V_{BE(SAT)}$  VS.  $I_C$ ,  $T_J = 150^\circ\text{C}$**

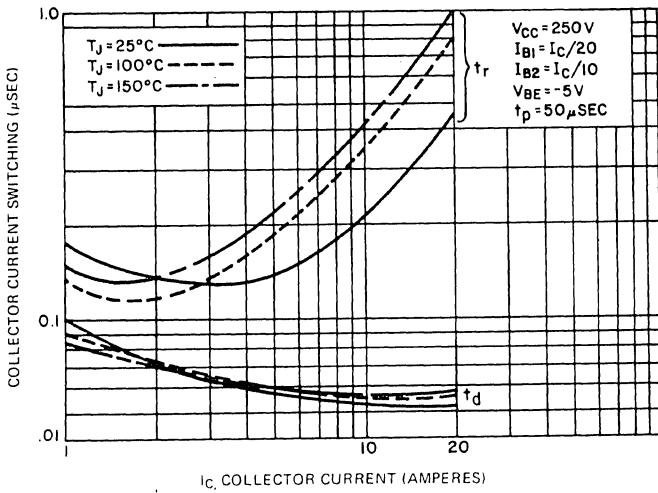


**FIGURE 11. CAPACITANCE ( $C_{CB0}$ )**

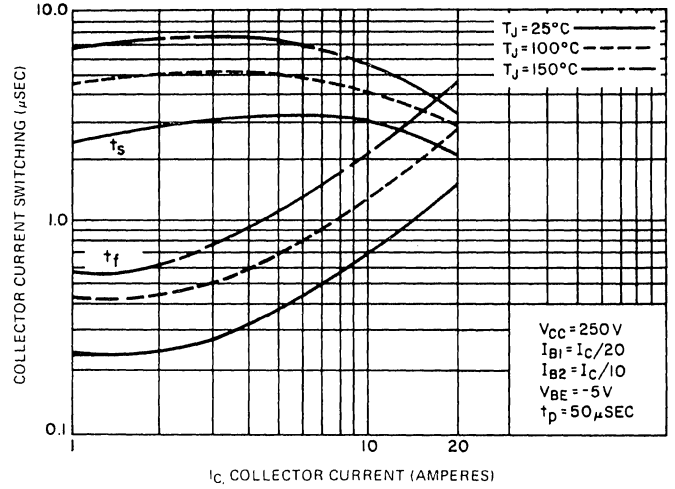


**FIGURE 12. TURN-ON TIME (RESISTIVE LOAD) (D64DS ONLY)**

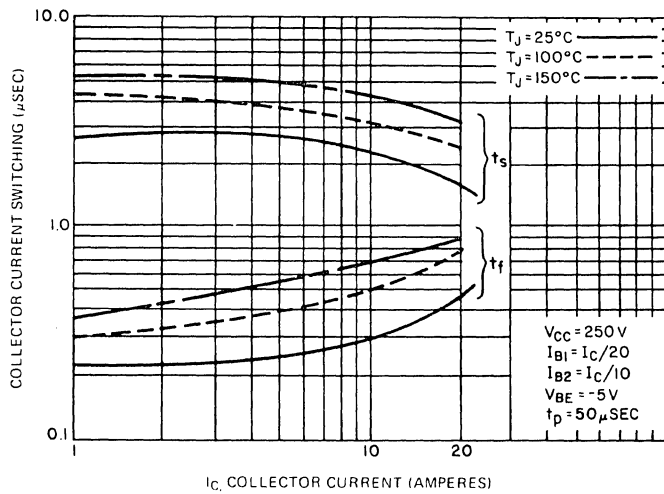
## TYPICAL CHARACTERISTICS



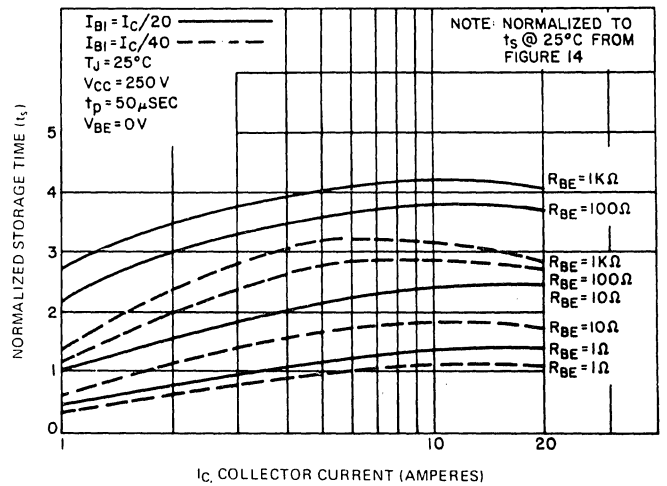
**FIGURE 13. TURN-ON TIME (RESISTIVE)  
(D64ES ONLY)**



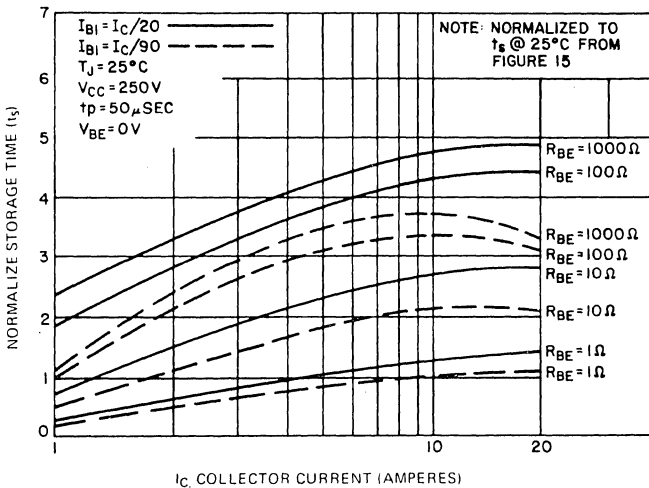
**FIGURE 14. TURN-OFF TIME (RESISTIVE)  
(D64DS ONLY)**



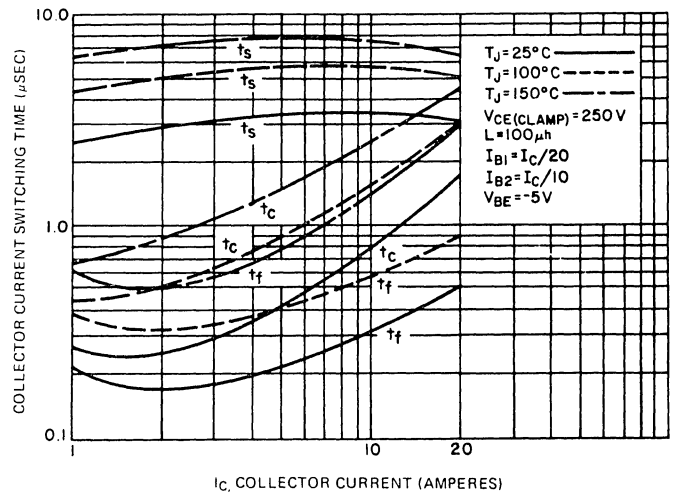
**FIGURE 15. TURN-OFF TIME (RESISTIVE)  
(D64ES ONLY)**



**FIGURE 16. NORMALIZED RESISTIVE  
SWITCHING STORAGE TIME ( $R_{BE}$  VARIATIONS)  
VS. COLLECTOR CURRENT  
(D64DS ONLY)**

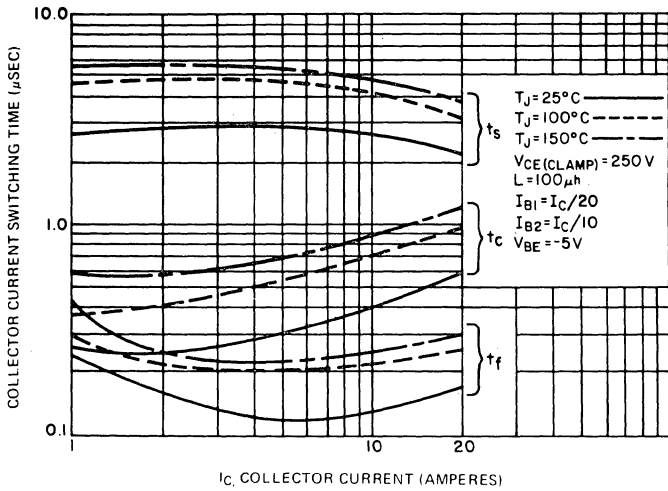


**FIGURE 17. NORMALIZED RESISTIVE  
SWITCHING STORAGE TIME ( $R_{BE}$  VARIATIONS)  
VS. COLLECTOR CURRENT  
(D64ES ONLY)**

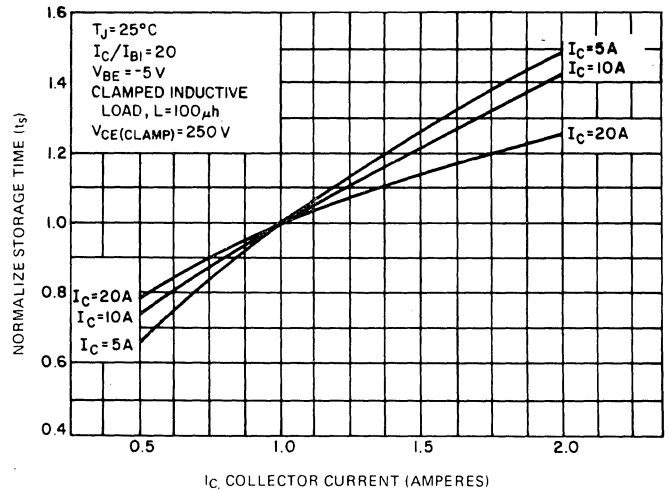


**FIGURE 18. CLAMPED INDUCTIVE  
TURN-OFF TIME  
(D64DS ONLY)**

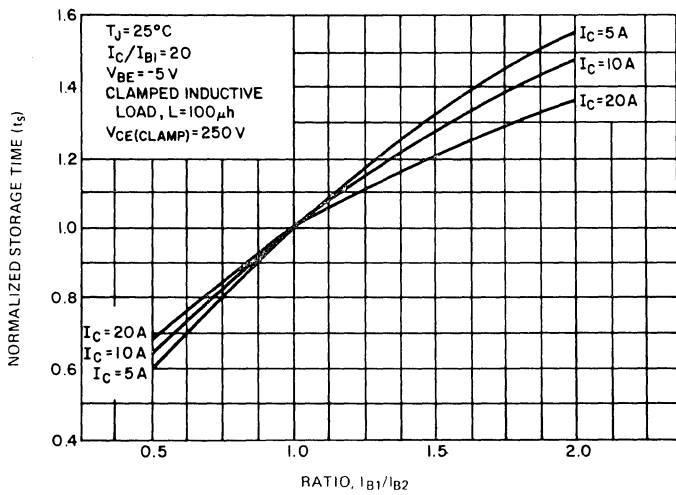
# TYPICAL CHARACTERISTICS



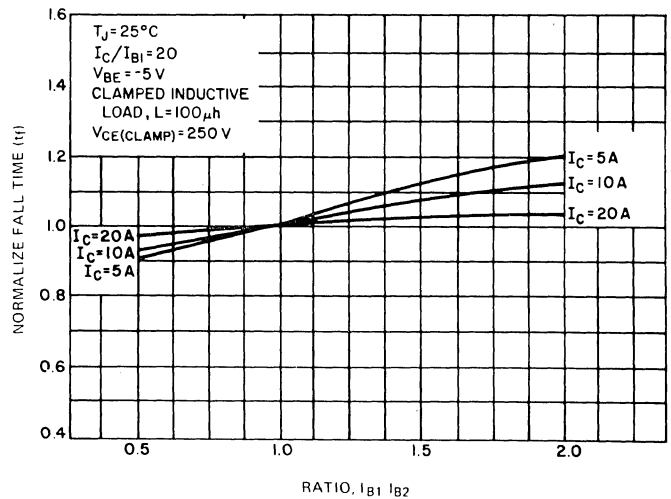
**FIGURE 19. CLAMPED INDUCTIVE TURN-OFF TIME (D64ES ONLY)**



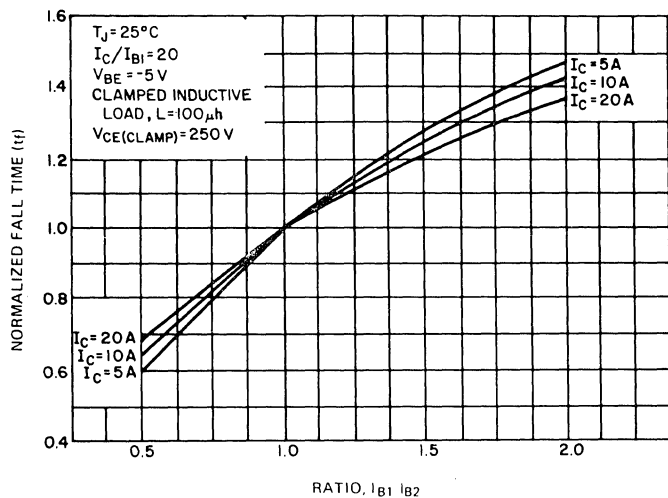
**FIGURE 20. STORAGE TIME VARIATION WITH  $I_{B2}$  (D64DS ONLY)**



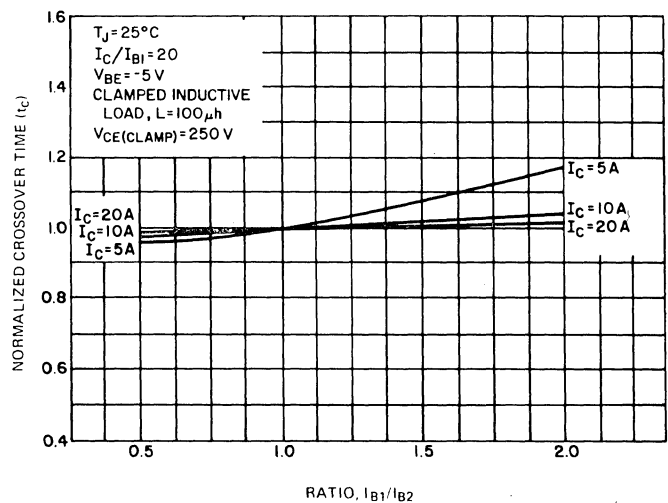
**FIGURE 21. STORAGE TIME VARIATION WITH  $I_{B2}$  (D64ES ONLY)**



**FIGURE 22. FALL TIME VARIATION WITH  $I_{B2}$  (D64DS ONLY)**

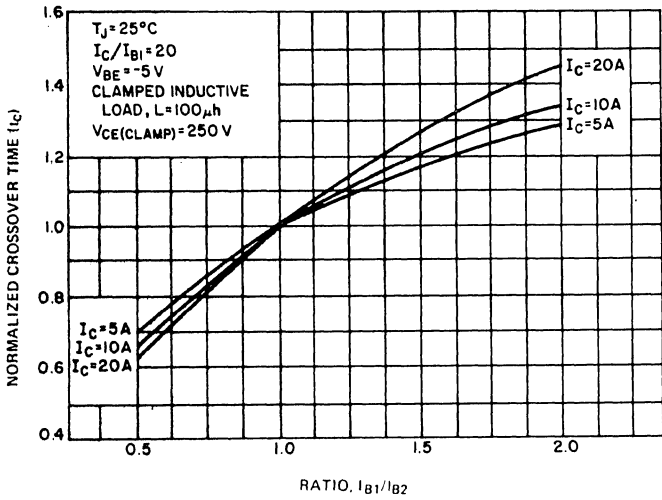


**FIGURE 23. FALL TIME VARIATION WITH  $I_{B2}$  (D64ES ONLY)**

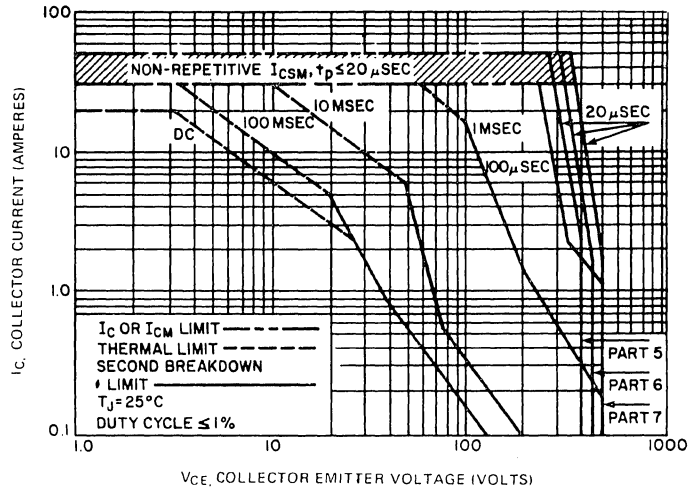


**FIGURE 24. CROSS-OVER TIME VARIATION WITH  $I_{B2}$  (D64DS ONLY)**

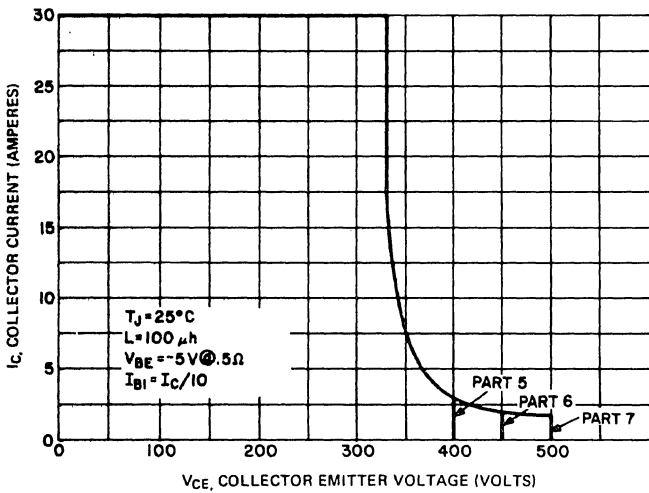
## TYPICAL CHARACTERISTICS



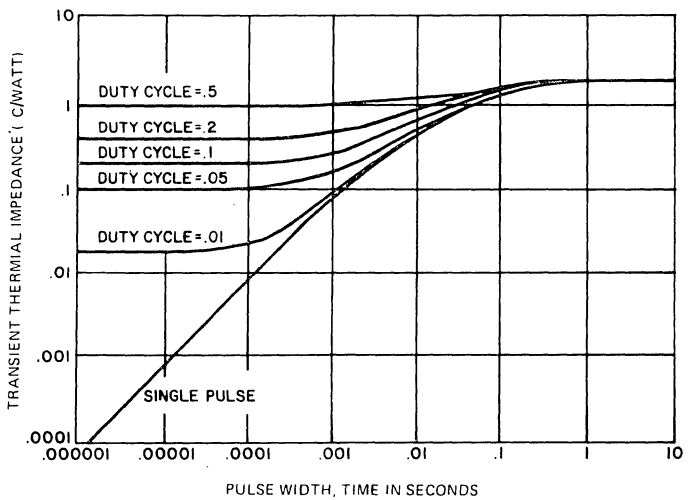
**FIGURE 25. CROSS-OVER TIME VARIATION WITH  $I_{B2}$  (D64ES ONLY)**



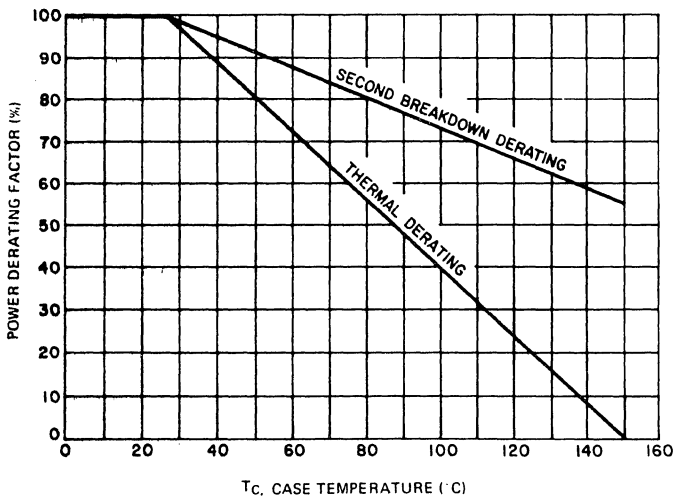
**FIGURE 26. FORWARD BIAS SAFE OPERATING AREA**



**FIGURE 27. REVERSE BIAS SAFE OPERATING AREA**

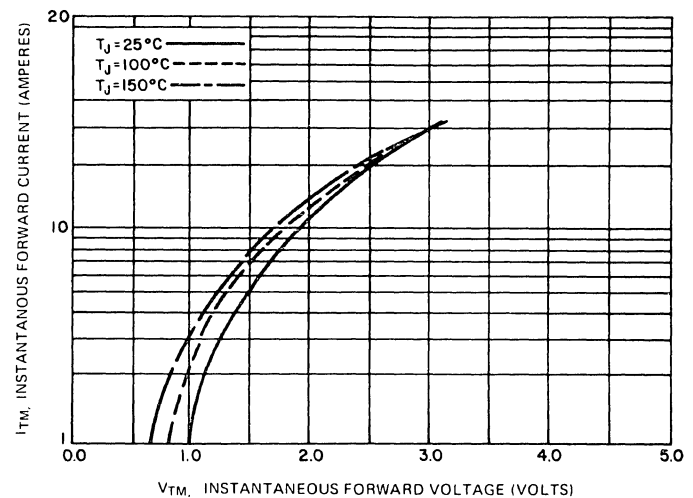


**FIGURE 28. TRANSIENT THERMAL RESPONSE**



**FIGURE 29. POWER DERATING**

## DIODE CHARACTERISTICS



**FIGURE 30. FORWARD CHARACTERISTICS**

# TYPICAL CHARACTERISTICS

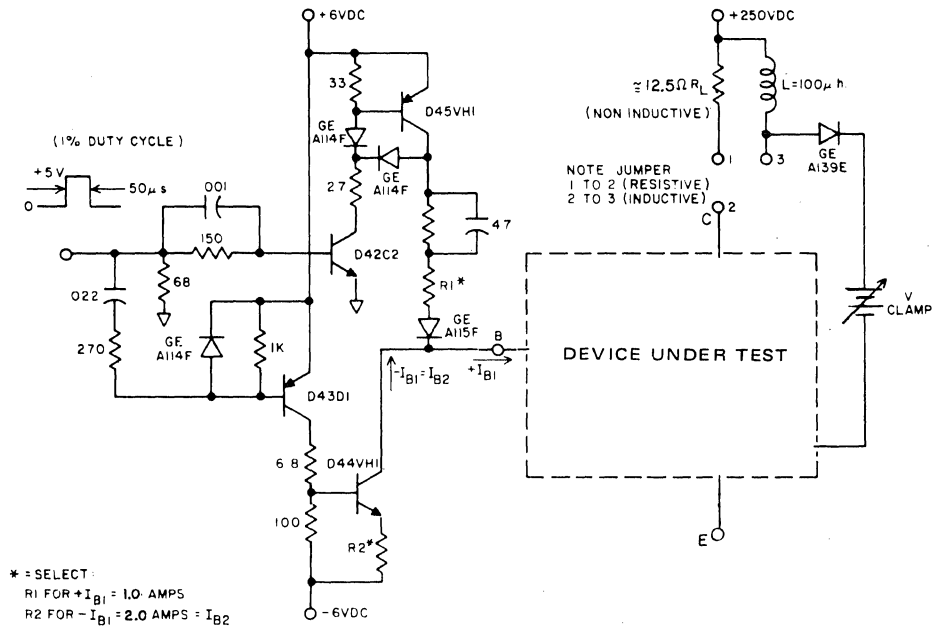


FIGURE 31. SWITCHING TIME TEST CIRCUIT